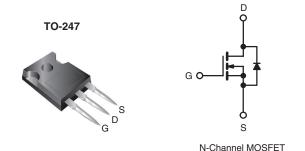


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	100			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.055		
Q <sub>g</sub> (Max.) (nC)	140			
Q <sub>gs</sub> (nC)	29			
Q <sub>gd</sub> (nC)	68			
Configuration	Single			



#### **FEATURES**

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Load (Ph) from	IRFP150PbF
Lead (Pb)-free	SiHFP150-E3
SnPb	IRFP150
SILL	SiHFP150

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	100	V	
Gate-Source Voltage	$V_{GS}$	± 20			
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I-	41		
	T <sub>C</sub> =100 °C	I <sub>D</sub>	29	Α	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	160			
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	830	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	41	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	19	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	230	W	
Peak Diode Recovery dV/dtc	dV/dt	5.5	V/ns		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	6-32 OF IVI3 SCIEW		1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 740  $\mu$ H,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 41 A (see fig. 12).
- c.  $I_{SD} \le 41$  A,  $dI/dt \le 300$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# **IRFP150**, **SiHFP150**

# Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65	

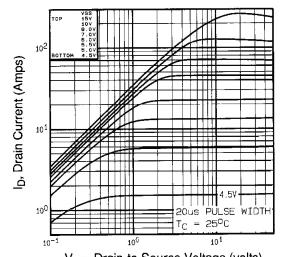
<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C,	unless otherv	vise noted					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I <sub>D</sub> = 1 mA	-	0.14	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zava Cata Valtaga Drain Current		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80 V, V	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 25 A <sup>b</sup>	-	-	0.055	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 25 \text{ V}, I_D = 25 \text{ A}^b$		13	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0  MHz,  see fig. 5		-	2800	-	pF
Output Capacitance	C <sub>oss</sub>			-	1100	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	280	-	
Total Gate Charge	Qg			-	-	140	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 41 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	29	
Gate-Drain Charge	Q <sub>gd</sub>		See lig. 0 and 13	-	-	68	
Turn-On Delay Time	t <sub>d(on)</sub>			-	16	-	
Rise Time	t <sub>r</sub>	Vpp = 5	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 41 A,		120	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$N_{DD} = 50 \text{ V}, I_{D} = 41 \text{ A},$ $N_{C} = 6.2 \Omega, R_{D} = 1.2 \Omega, \text{ see fig. } 10^{b}$		-	60	-	
Fall Time	t <sub>f</sub>			-	81	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s	1			•		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	41	- A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	160	
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 41  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 41 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	220	330	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.9	2.9	μС
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$				L <sub>D</sub> )	

#### Notes

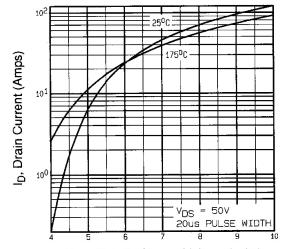
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s$ ; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $V_{DS}$ , Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C



V<sub>GS</sub>, Gate-to-Source Voltage (volts) Fig. 3 - Typical Transfer Characteristics

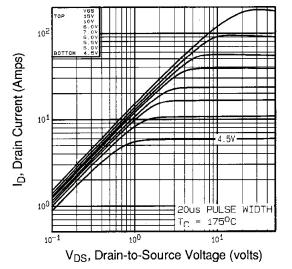


Fig. 2 - Typical Output Characteristics,  $T_C = 175$  °C

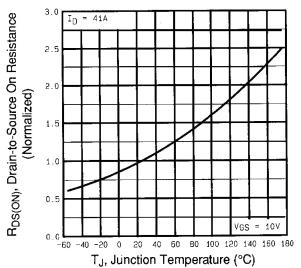


Fig. 4 - Normalized On-Resistance vs. Temperature

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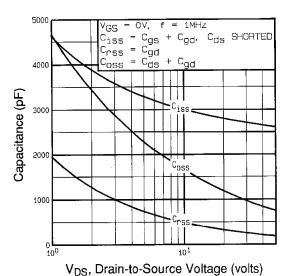


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

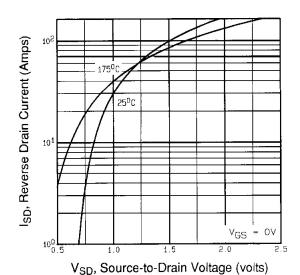


Fig. 7 - Typical Source-Drain Diode Forward Voltage

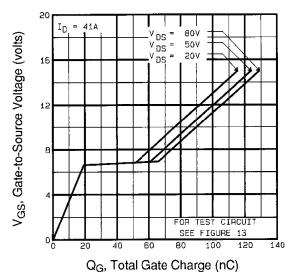


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

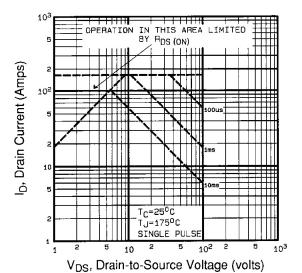


Fig. 2 - Fig. 8 - Maximum Safe Operating Area





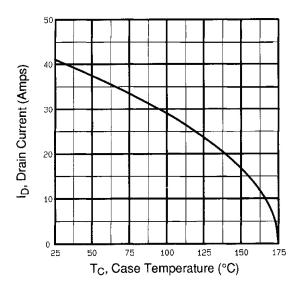


Fig. 9 - Maximum Drain Current vs. Case Temperature

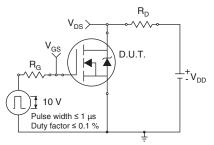


Fig. 10a - Switching Time Test Circuit

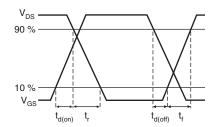
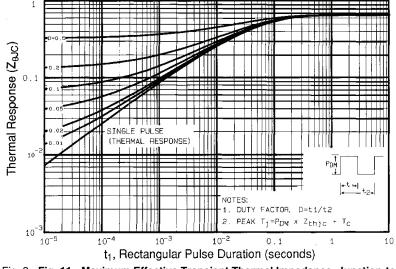


Fig. 10b - Switching Time Waveforms



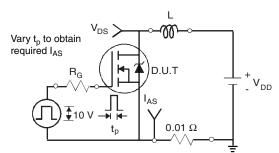


Fig. 12a - Unclamped Inductive Test Circuit

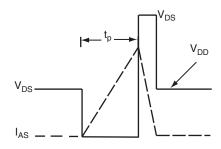


Fig. 12b - Unclamped Inductive Waveforms

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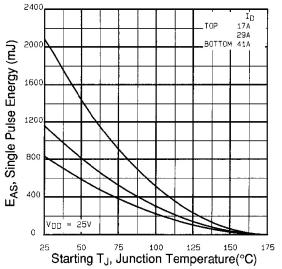


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

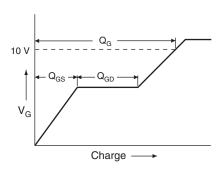


Fig. 13a - Basic Gate Charge Waveform

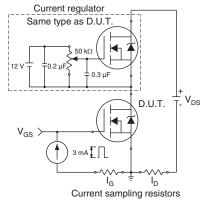
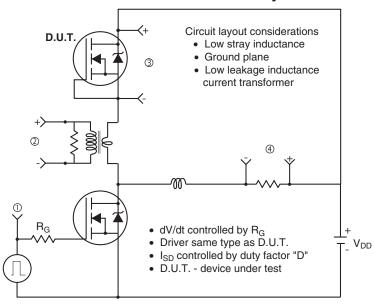


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



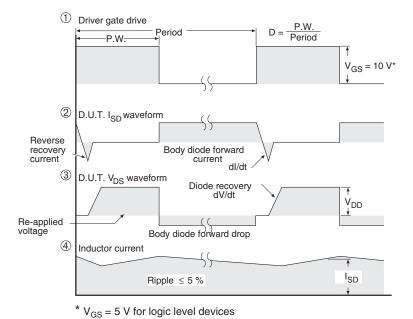


Fig. 14 - For N-Channel

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